

 Application/Control No.	Applicant(s)/Paten Reexamination	t under
10/717,540	MURAKAWA ET	AL.
Examiner	Art Unit	
David L. Lewis	2673	

SEARCHED					
Class	Subclass	Date	Examiner		
345	87-100, 204, 211, 904	12/11/2005	DL		
324	527-530	12/11/2005	DL		
324	750	12/11/2005	DL		
			-		

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
<u> </u>				
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST SEARCH keywords and subclass uspat and uspgpubs	12/11/2005	DL		
		-		